**Preferred Device** 

## **Triacs**

## **Silicon Bidirectional Thyristors**

Designed for high volume, low cost, industrial and consumer applications such as motor control; process control; temperature, light and speed control.

- Small Size Surface Mount DPAK Package
- Passivated Die for Reliability and Uniformity
- Blocking Voltage to 800 V
- On-State Current Rating of 4.0 Amperes RMS at 108°C
- High Immunity to dv/dt 500 V/µs at 125°C
- High Immunity to di/dt 6.0 A/ms at 125°C
- Device Marking: Logo, Device Type with "M" truncated, e.g., MAC4DCM: AC4DCM, Date Code

### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Repetitive Off–State Voltage <sup>(1)</sup> (T <sub>J</sub> = -40 to 125°C, Sine Wave, 50 to 60 Hz, Gate Open) MAC4DCM	VDRM, VRRM	600	Volts
MAC4DCN		800	
On–State RMS Current (Full Cycle Sine Wave, 60 Hz, T <sub>C</sub> = 108°C)	IT(RMS)	4.0	Amps
Peak Non-Repetitive Surge Current (One Full Cycle Sine Wave, 60 Hz, T <sub>J</sub> = 125°C)	ITSM	40	Amps
Circuit Fusing Consideration (t = 8.3 msec)	I <sup>2</sup> t	6.6	A <sup>2</sup> sec
Peak Gate Power (Pulse Width ≤ 10 μsec, T <sub>C</sub> = 108°C)	PGM	0.5	Watt
Average Gate Power (t = 8.3 msec, T <sub>C</sub> = 108°C)	PG(AV)	0.1	Watt
Peak Gate Current (Pulse Width ≤ 10 μsec, T <sub>C</sub> = 108°C)	I <sub>GM</sub>	0.5	Amp
Peak Gate Voltage (Pulse Width ≤ 10 μsec, T <sub>C</sub> = 108°C)	V <sub>GM</sub>	5.0	Volts
Operating Junction Temperature Range	TJ	-40 to 125	°C
Storage Temperature Range	T <sub>stg</sub>	-40 to 150	°C

<sup>(1)</sup> VDRM and VRRM for all types can be applied on a continuous basis. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the device are exceeded.



#### ON Semiconductor

http://onsemi.com

# TRIACS 4.0 AMPERES RMS 600 thru 800 VOLTS







D-PAK CASE 369 STYLE 6

D-PAK CASE 369A STYLE 6

PIN ASSIGNMENT			
1	Main Terminal 1		
2	Main Terminal 2		
3	Gate		
4	Main Terminal 2		

### **ORDERING INFORMATION**

Device	Package	Shipping
MAC4DCMT4	DPAK 369A	16mm Tape and Reel (2.5K/Reel)
MAC4DCM-1	DPAK 369	75 Units/Rail
MAC4DCNT4	DPAK 369A	16mm Tape and Reel (2.5K/Reel)
MAC4DCN-1	DPAK 369	75 Units/Rail

**Preferred** devices are recommended choices for future use and best overall value.

#### THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance — Junction to Case — Junction to Ambient — Junction to Ambient <sup>(1)</sup>	R <sub>Ð</sub> JC R <sub>Ð</sub> JA R <sub>Ð</sub> JA	3.5 88 80	°C/W
Maximum Lead Temperature for Soldering Purposes <sup>(2)</sup>	TL	260	°C

## **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted; Electricals apply in both directions)

Characteristic	Symbol	Min	Тур	Max	Unit		
OFF CHARACTERISTICS							
Peak Repetitive Blocking Current $(V_D = Rated \ V_{DRM}, \ V_{RRM}; \ Gate \ Open) \\ T_J = 25^{\circ}C \\ T_J = 125^{\circ}C$	I <sub>DRM,</sub> I <sub>RRM</sub>	_	_	0.01 2.0	mA		
ON CHARACTERISTICS	•	•	•				
Peak On–State Voltage(3) (I <sub>TM</sub> = ±6.0 A)	V <sub>TM</sub>		1.3	1.6	Volts		
Gate Trigger Current (Continuous dc) (V <sub>D</sub> = 12 V, R <sub>L</sub> = 100 $\Omega$ ) MT2(+), G(+) MT2(+), G(-) MT2(-), G(-)	l <sub>GT</sub>	8.0 8.0 8.0	12 18 22	35 35 35	mA		
Gate Trigger Voltage (Continuous dc) (V <sub>D</sub> = 12 V, R <sub>L</sub> = 100 $\Omega$ ) MT2(+), G(+) MT2(+), G(-) MT2(-), G(-)	VGT	0.5 0.5 0.5	0.8 0.8 0.8	1.3 1.3 1.3	Volts		
Gate Non–Trigger Voltage (Continuous dc) (V <sub>D</sub> = 12 V, R <sub>L</sub> = 100 $\Omega$ ) MT2(+), G(+); MT2(+), G(-); MT2(-), G(-) T <sub>J</sub> = 125°C	V <sub>GD</sub>	0.2	0.4	_	Volts		
Holding Current (V <sub>D</sub> = 12 V, Gate Open, Initiating Current = ±200 mA)	lн	6.0	22	35	mA		
Latching Current (V <sub>D</sub> = 12 V, I <sub>G</sub> = 35 mA) MT2(+), G(+) MT2(+), G(-) MT2(-), G(-)	IL.	_ _ _	30 50 20	60 80 60	mA		

#### **DYNAMIC CHARACTERISTICS**

Characteristic	Symbol	Min	Тур	Max	Unit
Rate of Change of Commutating Current ( $V_D$ = 400 V, $I_{TM}$ = 4.0 A, Commutating dv/dt = 18 V/ $\mu$ sec, Gate Open, $T_J$ = 125°C, f = 250 Hz, CL = 5.0 $\mu$ F, LL = 20 mH, No Snubber) See Figure 16	di/dt(c)	6.0	8.4	_	A/ms
Critical Rate of Rise of Off–State Voltage (V <sub>D</sub> = 0.67 X Rated V <sub>DRM</sub> , Exponential Waveform, Gate Open, T <sub>J</sub> = 125°C)	dv/dt	500	1700	_	V/μs

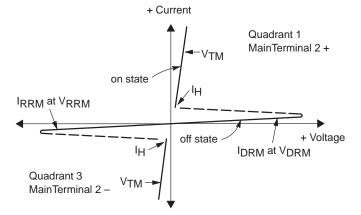
<sup>(1)</sup> Surface mounted on minimum recommended pad size.

<sup>(2) 1/8&</sup>quot; from case for 10 seconds.

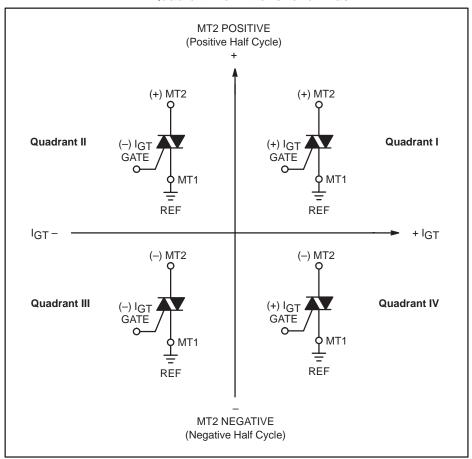
<sup>(3)</sup> Pulse Test: Pulse Width  $\leq$  2.0 msec, Duty Cycle  $\leq$  2%.

## Voltage Current Characteristic of Triacs (Bidirectional Device)

Symbol	Parameter
VDRM	Peak Repetitive Forward Off State Voltage
IDRM	Peak Forward Blocking Current
VRRM	Peak Repetitive Reverse Off State Voltage
IRRM	Peak Reverse Blocking Current
$V_{TM}$	Maximum On State Voltage
lΗ	Holding Current



#### **Quadrant Definitions for a Triac**



All polarities are referenced to MT1.

With in-phase signals (using standard AC lines) quadrants I and III are used.

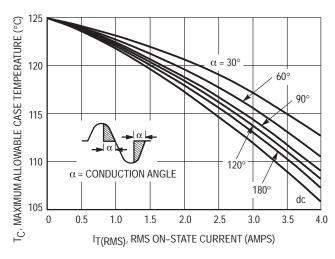


Figure 1. RMS Current Derating

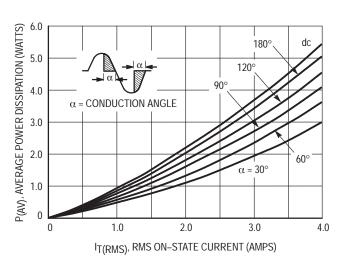


Figure 2. On-State Power Dissipation

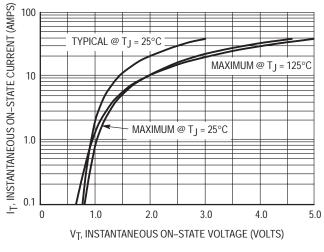
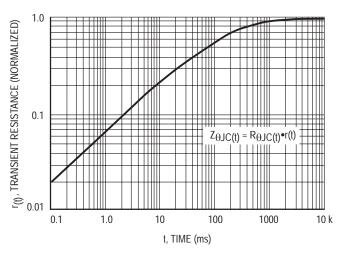


Figure 3. On-State Characteristics



**Figure 4. Transient Thermal Response** 

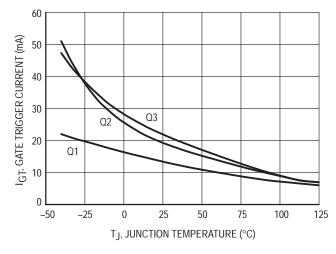


Figure 5. Typical Gate Trigger Current versus Junction Temperature

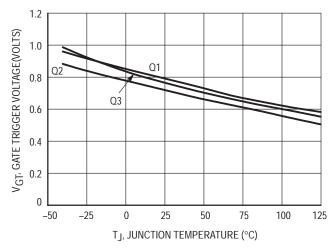
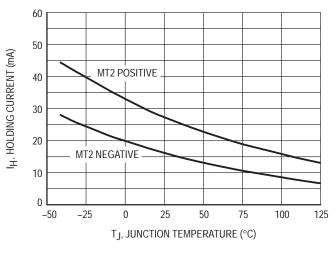


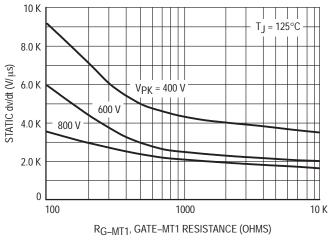
Figure 6. Typical Gate Trigger Voltage versus
Junction Temperature



120 100 I<sub>L</sub>, LATCHING CURRENT (mA) Q2 80 60 Q1 40 Q3 20 0 -25 0 25 50 75 100 -50 125 T<sub>J</sub>, JUNCTION TEMPERATURE (°C)

Figure 7. Typical Holding Current versus Junction Temperature

Figure 8. Typical Latching Current versus Junction Temperature



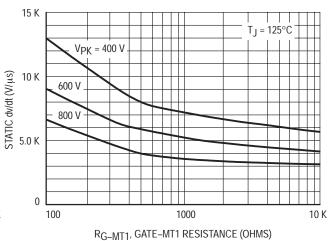
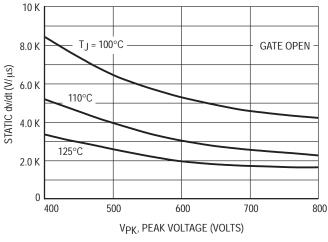


Figure 9. Exponential Static dv/dt versus Gate-MT1 Resistance, MT2(+)

Figure 10. Exponential Static dv/dt versus Gate–MT1 Resistance, MT2(–)



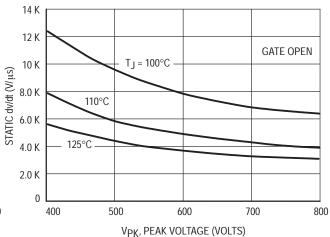


Figure 11. Exponential Static dv/dt versus Peak Voltage, MT2(+)

Figure 12. Exponential Static dv/dt versus Peak Voltage, MT2(–)

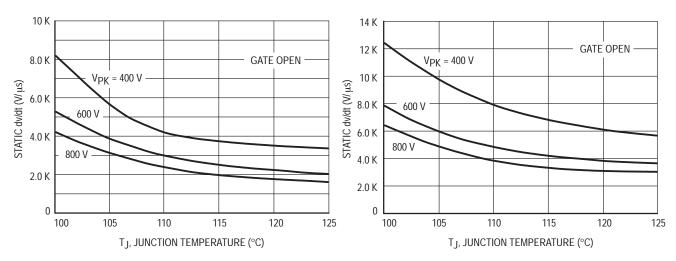


Figure 13. Typical Exponential Static dv/dt versus Junction Temperature, MT2(+)

Figure 14. Typical Exponential Static dv/dt versus Junction Temperature, MT2(-)

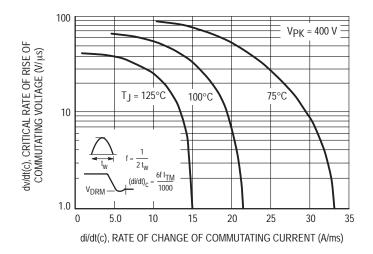
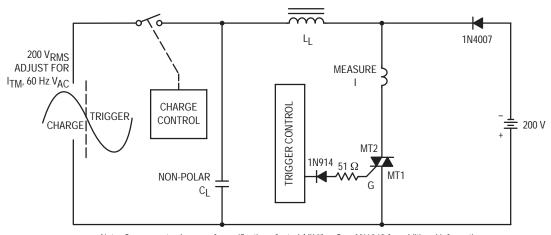


Figure 15. Critical Rate of Rise of Commutating Voltage



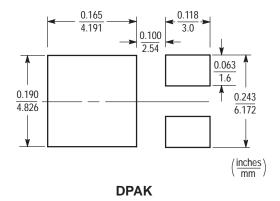
Note: Component values are for verification of rated  $(di/dt)_C$ . See AN1048 for additional information.

Figure 16. Simplified Test Circuit to Measure the Critical Rate of Rise of Commutating Current (di/dt)<sub>C</sub>

#### MINIMUM RECOMMENDED FOOTPRINT FOR SURFACE MOUNTED APPLICATIONS

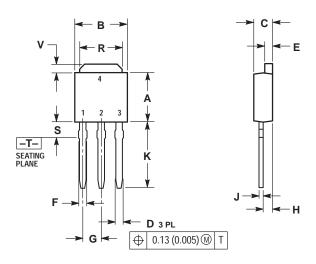
Surface mount board layout is a critical portion of the total design. The footprint for the semiconductor packages must be the correct size to insure proper solder connection

interface between the board and the package. With the correct pad geometry, the packages will self align when subjected to a solder reflow process.



#### **PACKAGE DIMENSIONS**

D-PAK CASE 369-07 ISSUE L



#### NOTES:

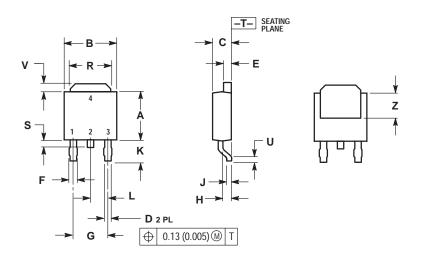
- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
   CONTROLLING DIMENSION: INCH.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.250	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.033	0.040	0.84	1.01
F	0.037	0.047	0.94	1.19
G	0.090 BSC		2.29 BSC	
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.175	0.215	4.45	5.46
S	0.050	0.090	1.27	2.28
V	0.030	0.050	0.77	1.27

STYLE 6: PIN 1. MT1 2. MT2 3. GATE

2. MT2 3. GATE 4. MT2

D-PAK CASE 369A-13 **ISSUE Z** 



- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: INCH.

	INC	HES	MILLIMETERS			
DIM	MIN	MAX	MIN	MAX		
Α	0.235	0.250	5.97	6.35		
В	0.250	0.265	6.35	6.73		
С	0.086	0.094	2.19	2.38		
D	0.027	0.035	0.69	0.88		
Е	0.033	0.040	0.84	1.01		
F	0.037	0.047	0.94	1.19		
G	0.180 BSC		4.58 BSC			
Н	0.034	0.040	0.87	1.01		
J	0.018	0.023	0.46	0.58		
K	0.102	0.114	2.60	2.89		
L	0.090	BSC	2.29 BSC			
R	0.175	0.215	4.45	5.46		
S	0.020	0.050	0.51	1.27		
U	0.020		0.51			
٧	0.030	0.050	0.77	1.27		
7	U 130		3 51			

STYLE 6:

PIN 1. MT1 2. MT2 3. GATE 4. MT2





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